

Faculté des arts et des sciences  
Département de chimie

# Surface Plasmon Resonance (SPR) Spectroscopy

*Theory, Instrumentation & Applications*

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CHEM 634

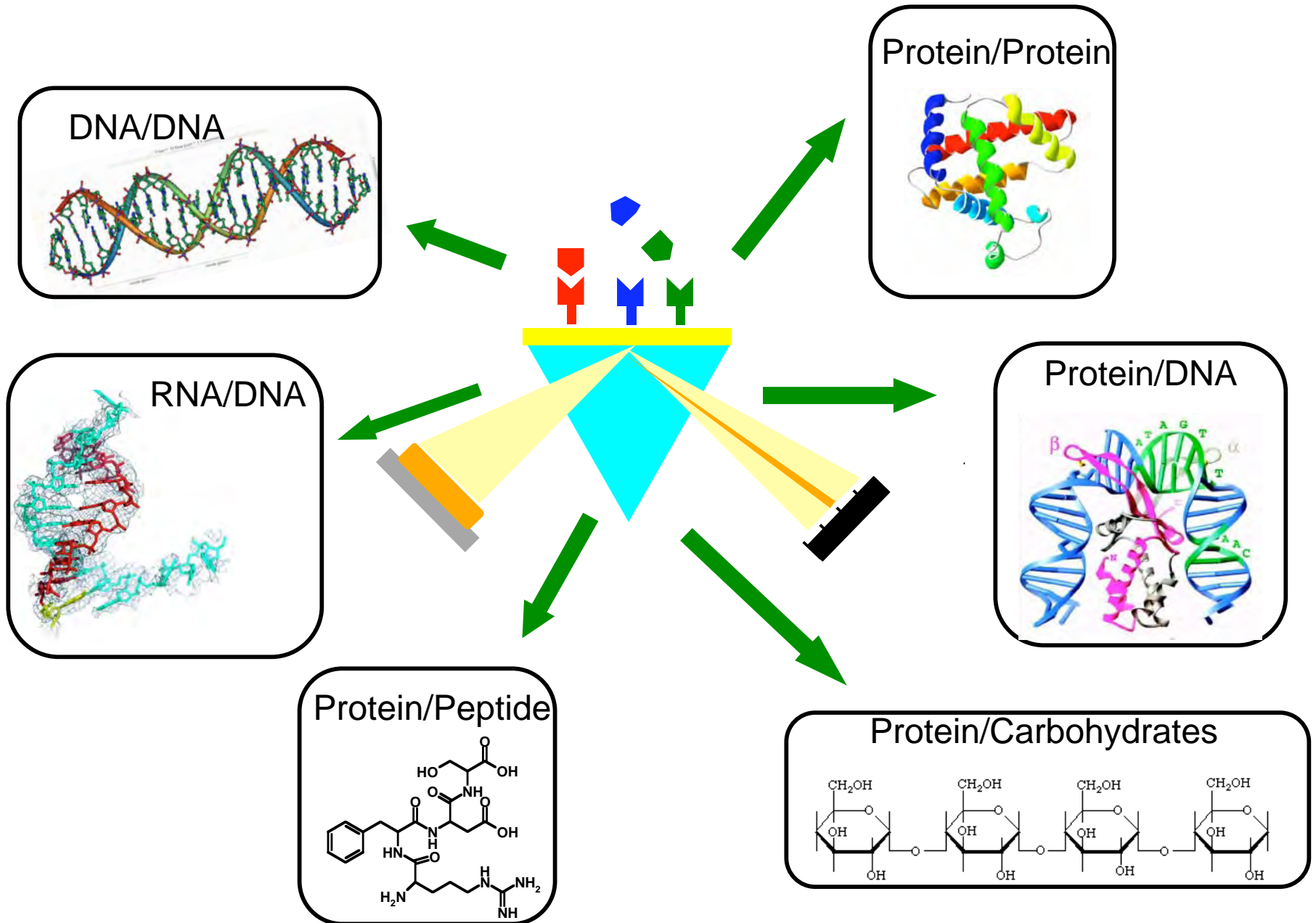
McGill University

January 26, 2007

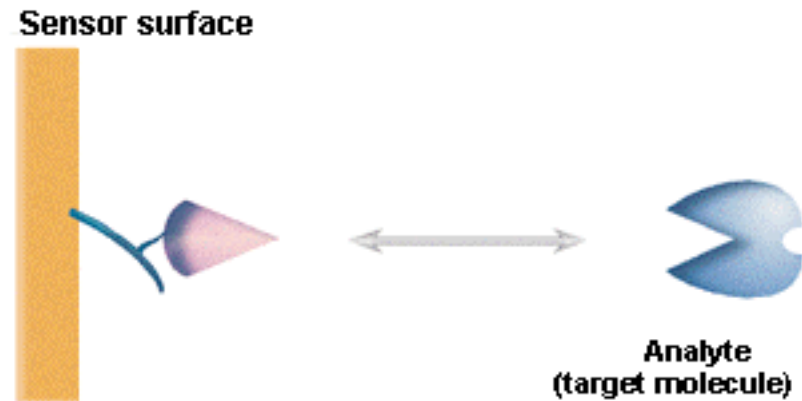
## SPR Spectroscopy - Overview:

- ❖ The detection principle relies on an electron charge density wave phenomenon that arises at the surface of a metallic film when light is reflected at the film under specific conditions.
- ❖ Molecular adsorption/desorption events are measured as a change in the refractive index at the metal film surface (“sensing surface”).
- ❖ Advantages:
  - Label-free detection technique
  - Distinguishes surface-bound material from bulk material
  - Monitor molecular interactions in real-time (kinetics)
  - Highly-sensitive ( $\Delta d_{\text{film}}$  of  $\sim 1\text{-}2 \text{ \AA}$  or nanograms of adsorbed mass)
  - Works in turbid or opaque samples

# Biological Applications of SPR

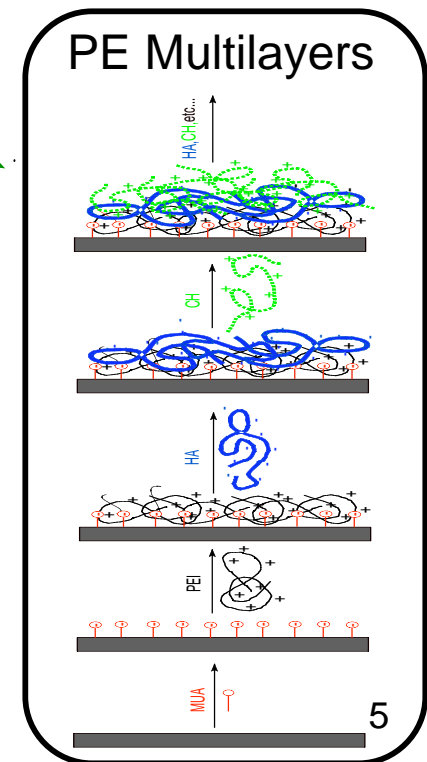
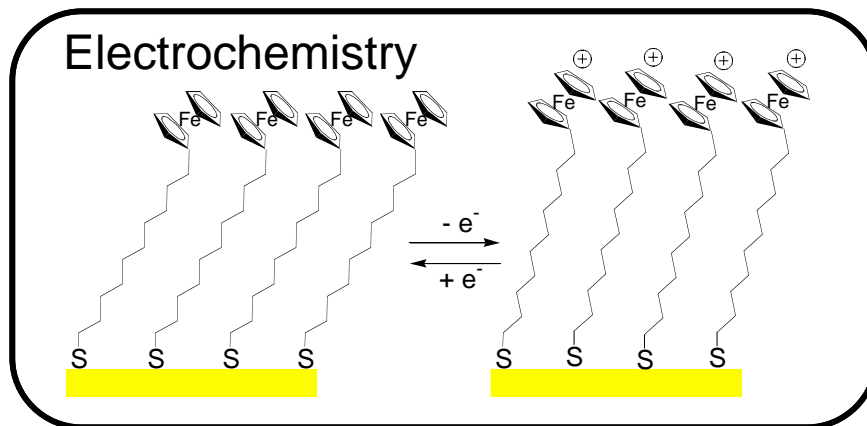
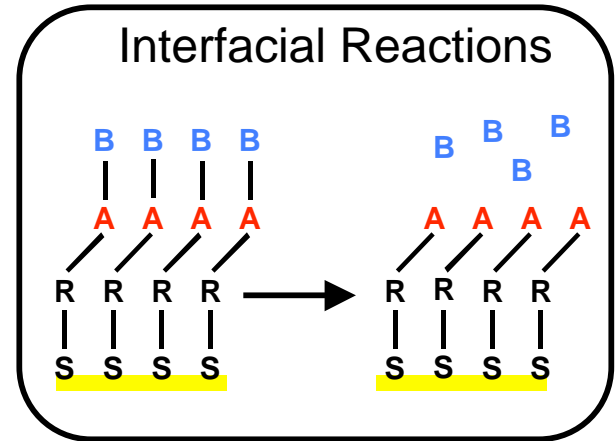
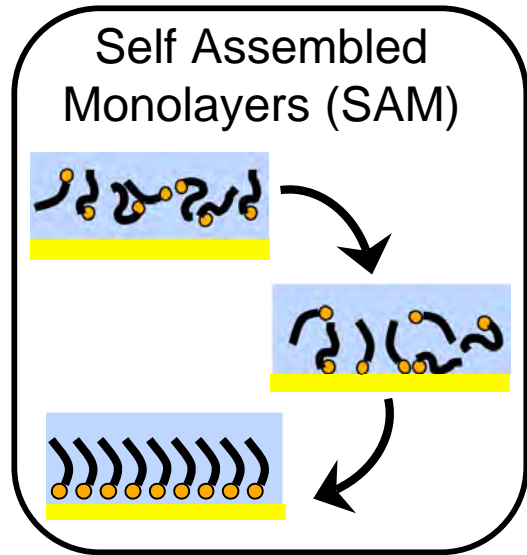


## Basic Principle

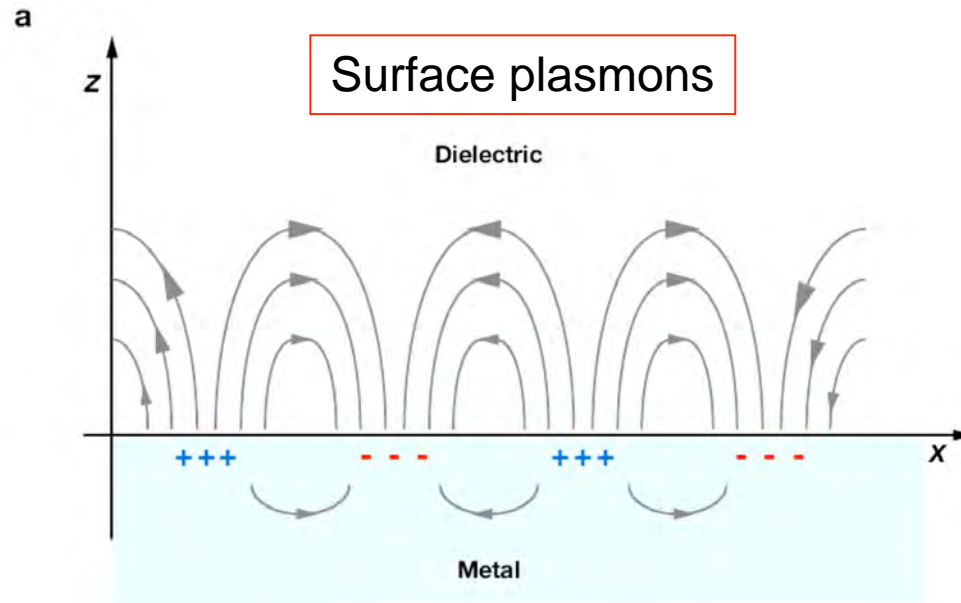


- A *binding molecule* is bound to the sensor surface (eg. a peptide)
- Another (*the analyte*) is passed over the surface and binds to it.

# Other Areas of Application

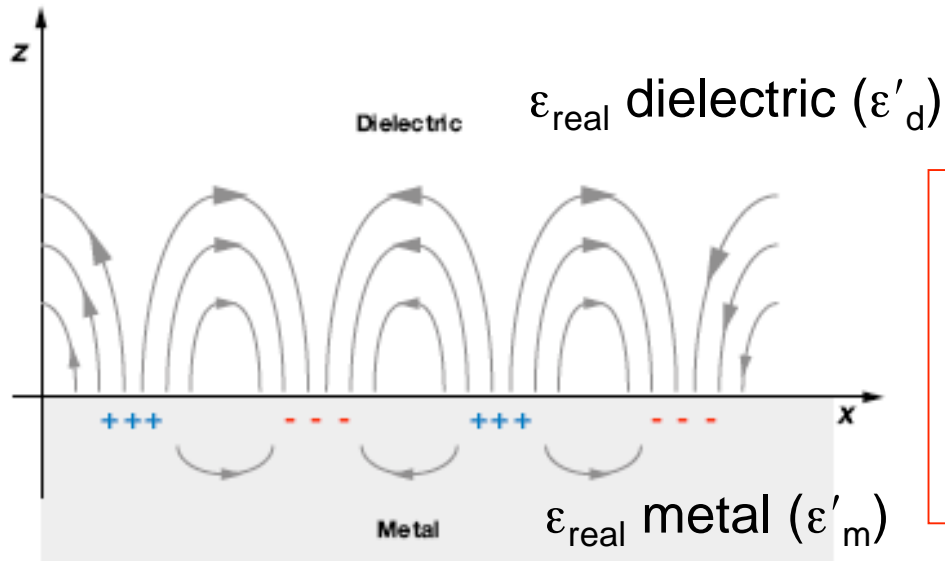


# Surface plasmons



- ❖ Plasmons are collective charge density oscillations of the nearly free electron gas in a metal.
- ❖ Plasmons can be excited both in the bulk and on the surface of a metal.
- ❖ Surface plasmons or surface plasmon polaritons are surface electromagnetic waves that propagate parallel along a metal/dielectric interface.

## Existence of electronic surface plasmons



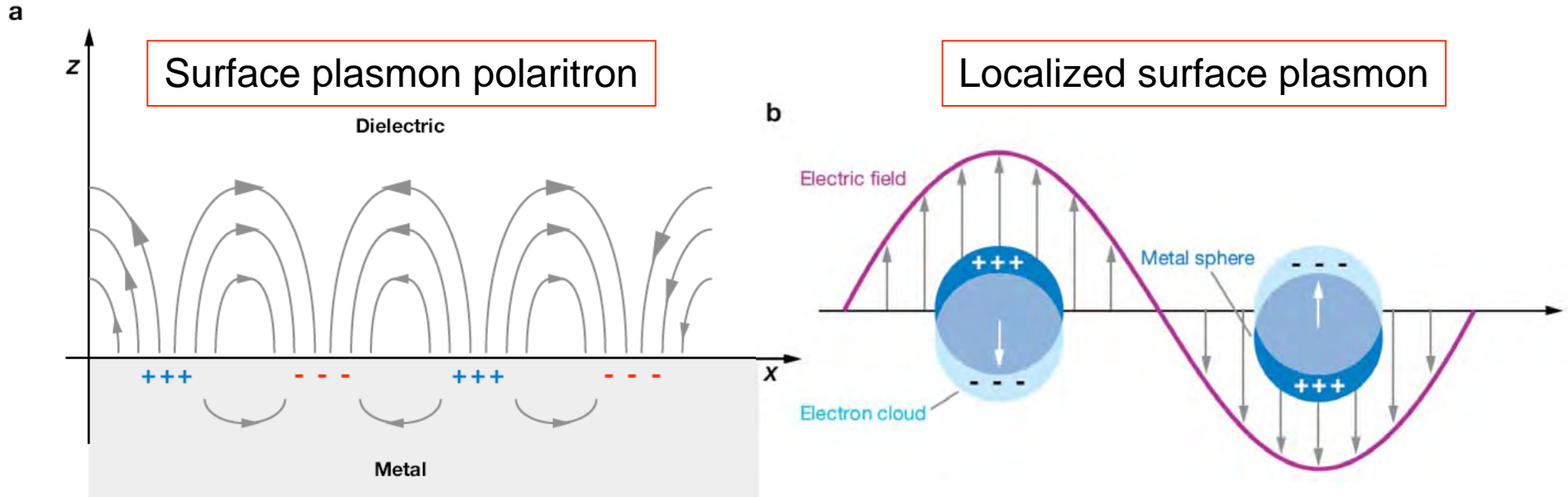
- ❖ Conditions to be met:
  - ❖  $\epsilon_{\text{real}}$  of the metal must be negative
  - ❖  $|\epsilon_{\text{real}}|$  of metal  $>$   $\epsilon_{\text{real}}$  of dielectric

- ❖ Conditions are met in the IR-visible wavelength region for air/metal and water/metal interfaces (where  $\epsilon'_m$  is negative and  $\epsilon'_d$  of air or water is positive). Typical metals that support surface plasmons are silver and gold.

- ❖ Electronic surface plasmons obey the following dispersion relation:

$$k_{\text{SP}} = \frac{\omega}{c} \sqrt{\frac{\epsilon_d \epsilon_m}{\epsilon_d + \epsilon_m}}$$

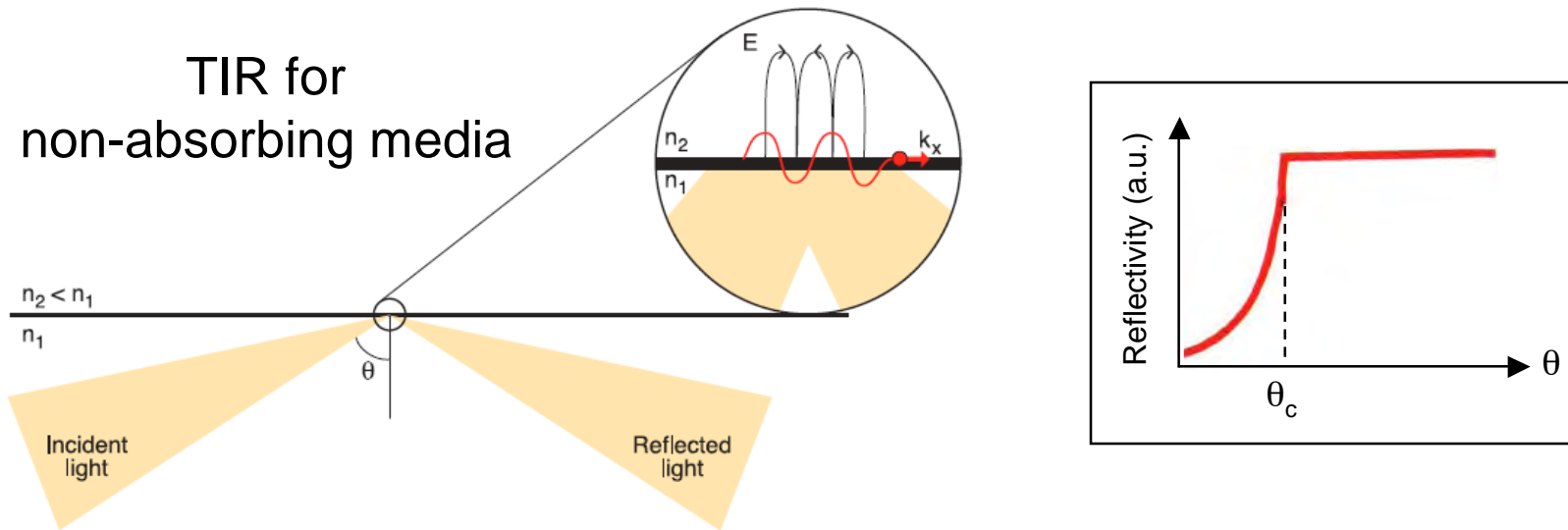
# SPR vs. LSPR



- ❖ The excitation of surface plasmons by light is denoted as:
  - ❖ surface plasmon resonance (SPR) for planar surfaces
  - ❖ localized surface plasmon resonance (LSPR) for nanometer-sized metallic structures.



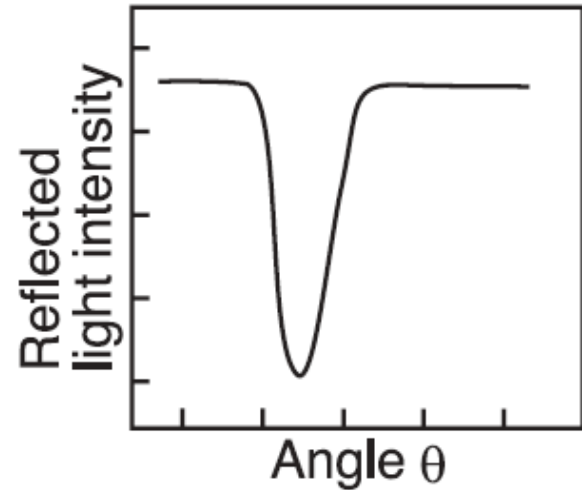
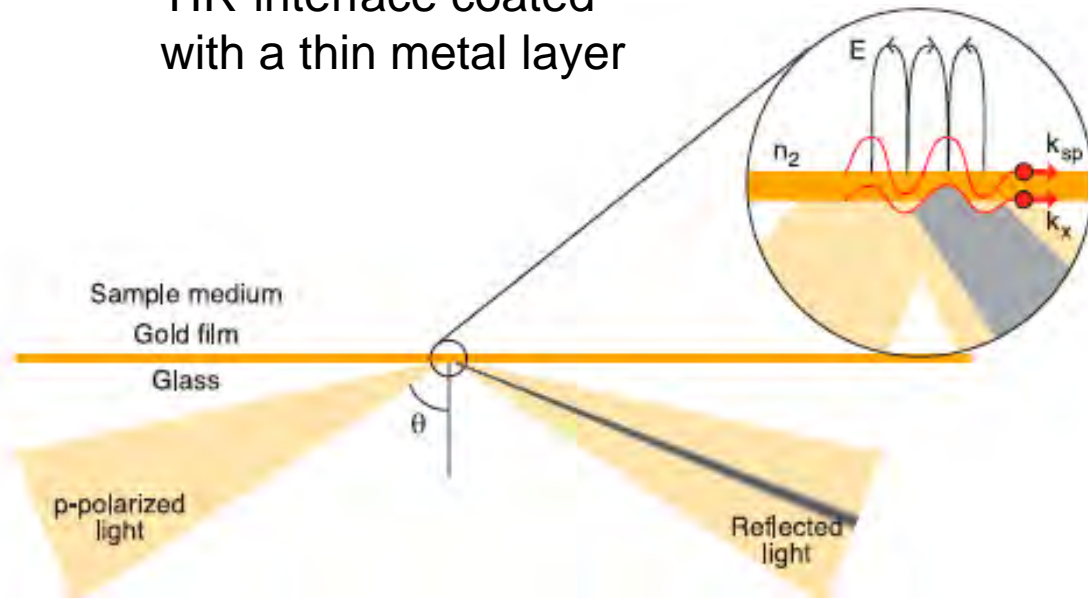
# Total Internal Reflection (TIR) phenomenon



- ❖ The fully reflected beam leaks an electrical field intensity (i.e. evanescent field wave) into the low refractive index medium.
- ❖ No photons exit the reflecting surface but their electric field decreases exponentially with distance from the interface, decaying over a distance of  $\sim 1/4$  wavelength beyond the surface.
- ❖ If the lower refractive index media has a non-zero absorption coefficient, the evanescent field wave may transfer the matching photon energy to the medium.

# SPR phenomenon

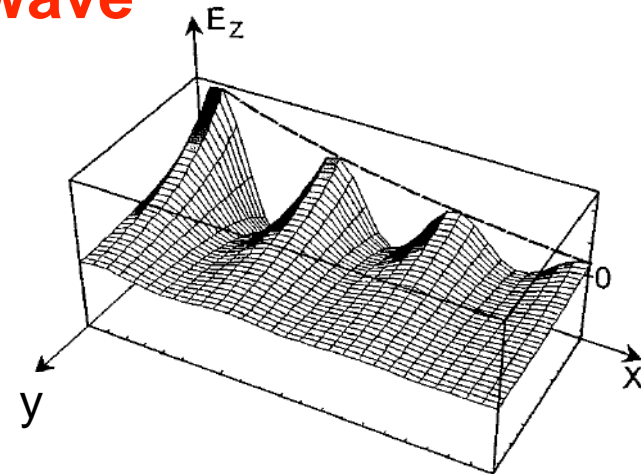
TIR-interface coated  
with a thin metal layer



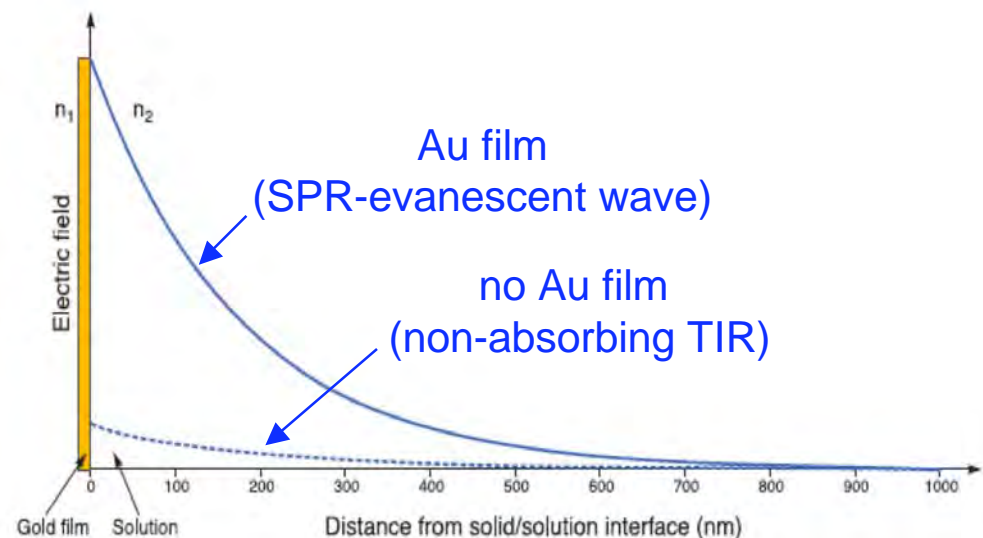
- ❖ Under specific conditions (i.e. incident angle of the light beam or wavelength ), the electromagnetic field component of the p-polarized light penetrates the metal layer, and energy is transferred to the metal's electrons.
- ❖ This energy transfer produces surface plasmon polaritons at the metal-medium interface.
- ❖ As a result of the energy transfer, there is a decrease in the reflected light intensity (gray region) at a specific angle of incidence.

## SPR-evanescent wave

- The surface plasmon wave propagates in the x- and y-directions along the metal-dielectric interface, for distances of ~ tens to hundreds of microns and decays evanescently in the z-direction (into the low refractive index medium) with 1/e decay lengths on the order of 200 nm.
- Due to its electromagnetic and surface propagating nature, the surface plasmon wave enhances the evanescent electric field amplitude.



(SPR-evanescent wave)



## Characteristics of the SPR evanescent wave

Table 1

Major characteristics of surface plasma waves (SPW) at the metal–water interface<sup>a</sup>

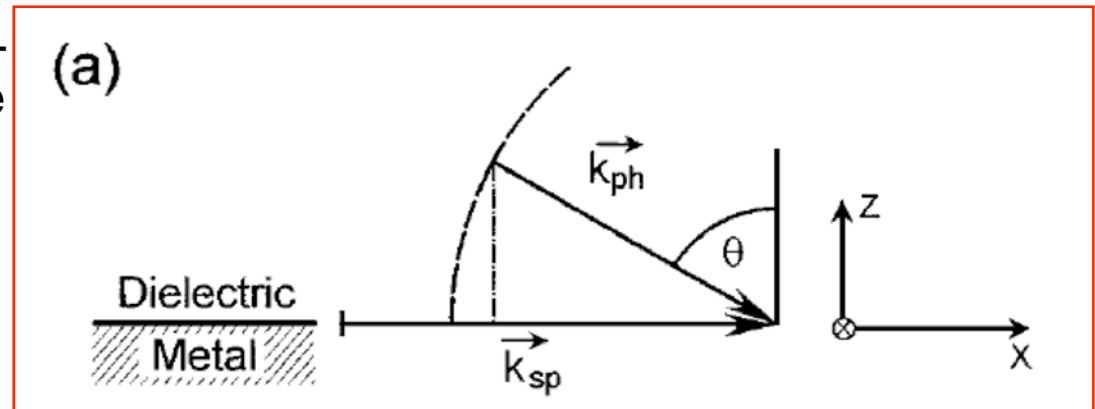
Metal layer supporting SPW	Gold	
Wavelength	$\lambda = 630 \text{ nm}$	$\lambda = 850 \text{ nm}$
Propagation length ( $\mu\text{m}$ )	3	24
Penetration depth into metal (nm)	29	25
Penetration depth into dielectric (nm)	162	400
Concentration of field in dielectric (%)	85	94

# Surface plasmon excitation: energy and momentum matching

- For plasmon excitation by a photon to take place, the energy and momentum of these quantum-particles must both be conserved during the photon transformation into a plasmon.
- This requirement is met when the wavevector for the photon  $k_{ph}$  and plasmon  $k_{sp}$  are equal in magnitude and direction for the same frequency of the waves.
- Light falling directly on the metal-dielectric interface cannot couple into the surface plasmon since matching of both  $\omega$  and  $k_x$  is not possible.
- For coupling to take place, the value of  $k_x$  of the incident light must be increased.

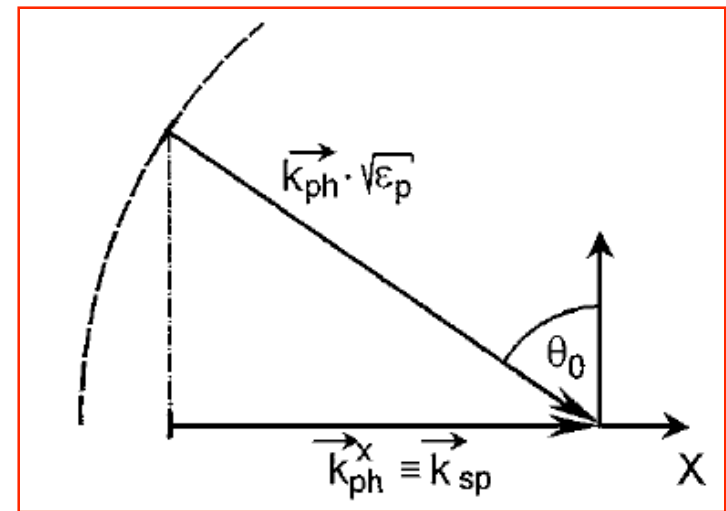
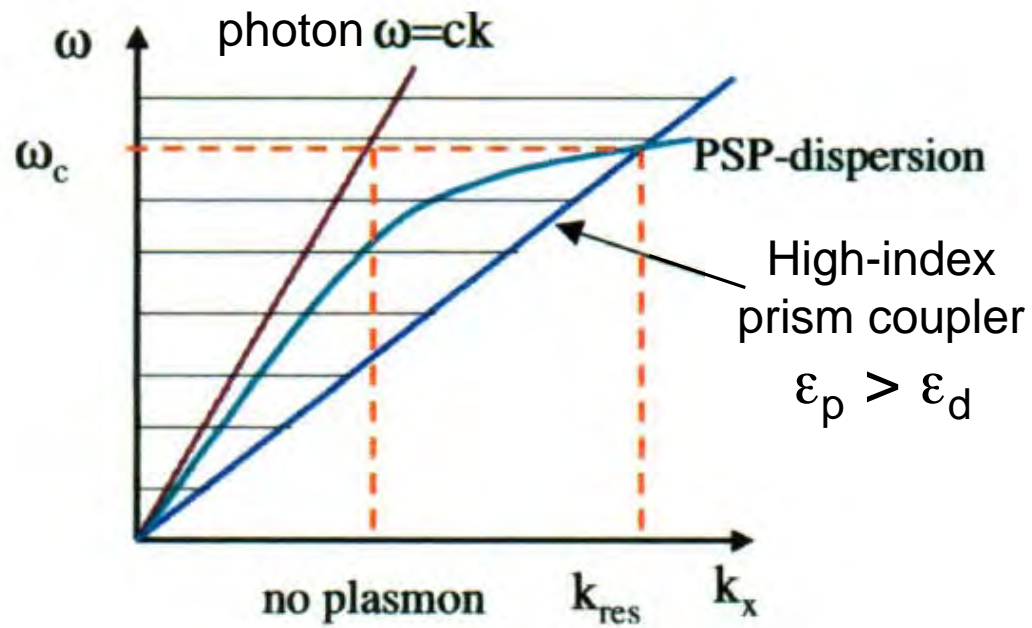
$$k_{sp} = \frac{\omega}{c} \sqrt{\frac{\epsilon_m \cdot \epsilon_d}{(\epsilon_m + \epsilon_d)}}$$

$$k_{ph} = \frac{\omega}{c} \cdot \sqrt{\epsilon_d}$$



$$|\vec{k}_{ph}| < |\vec{k}_{sp}| \text{ (for all } \Theta) \quad 13$$

# Surface plasmon excitation: prism couplers

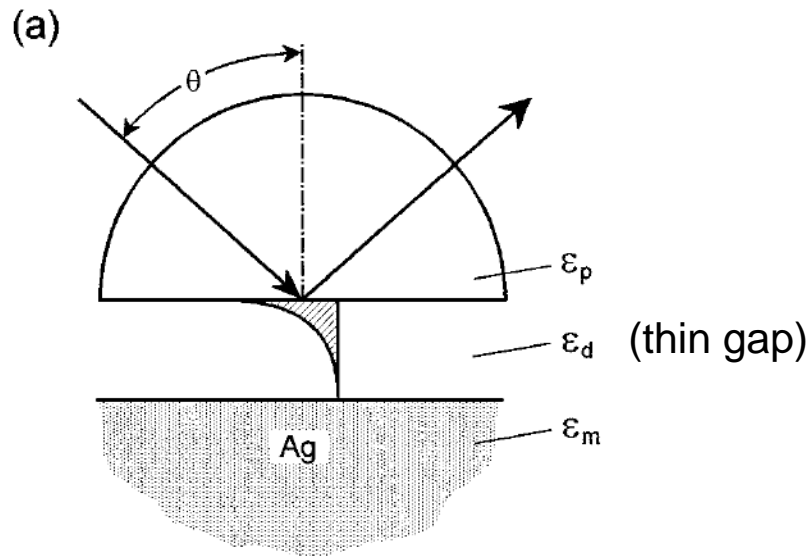


at the resonance angle  $\theta_0$

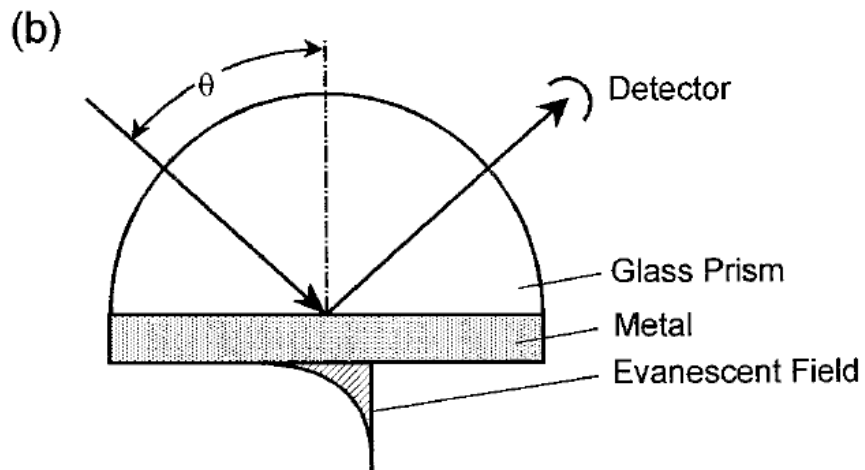
## Effect of molecular adsorption/binding on SPR

- ❖ Because the plasmon electric field penetrates a short distance into the lower refractive index medium, the conditions for SPR are sensitive to the refractive index  $n$  at the metal-dielectric interface.
- ❖ A change in the bulk refractive index of the dielectric medium and the adsorption or desorption of molecules from the metal surface changes the refractive index at the metal-dielectric interface and results in a change in the velocity of the plasmons.
- ❖ This change in plasmon velocity alters the incident light vector required for SPR and minimum reflection.
- ❖ The exact position of resonance bears information on the interfacial mass coverage/thickness of the interfacial layer.

## SPP excitation configurations



Otto configuration



Kretschmann ATR configuration



## SPR-based measurements

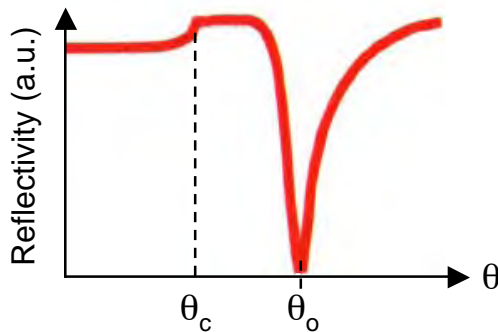
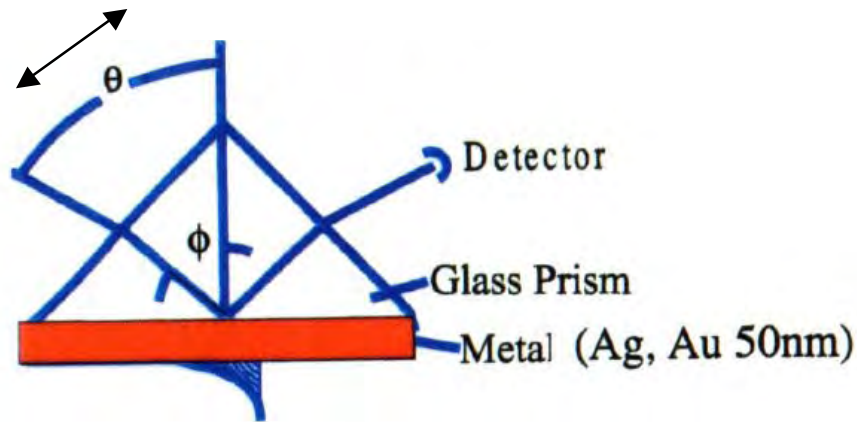
- Resonance angle shift
- Imaging/microscopy
- Wavelength shift (FT-SPR)

*The aim of SPR instrumentation is to determine the resonance position as precisely as possible and with the best time resolution.*

## SPR-based measurements

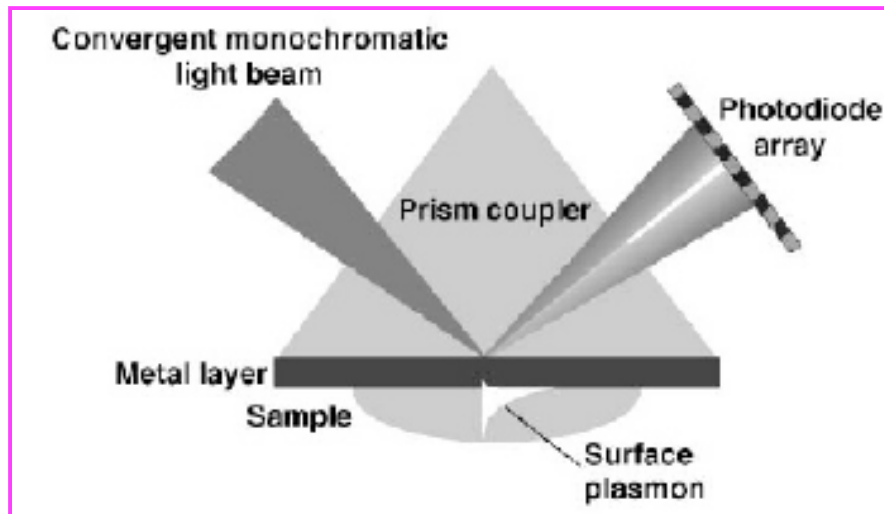
- **Resonance angle shift**
- Imaging/microscopy
- Wavelength shift (FT-SPR)

## Resonance angle shift measurements: principle



- Metal-coated high-refractive index prism (BK7, sapphire, LaSFN9, SF10, etc.)
- ATR/Kretschmann configuration
- Single wavelength p-polarized incident light
- The reflected light intensity is measured as a function of the angle of incidence  $\Theta$ .
- The angle scan changes the wave-vector  $k_x$  of the incident light onto the prism base.

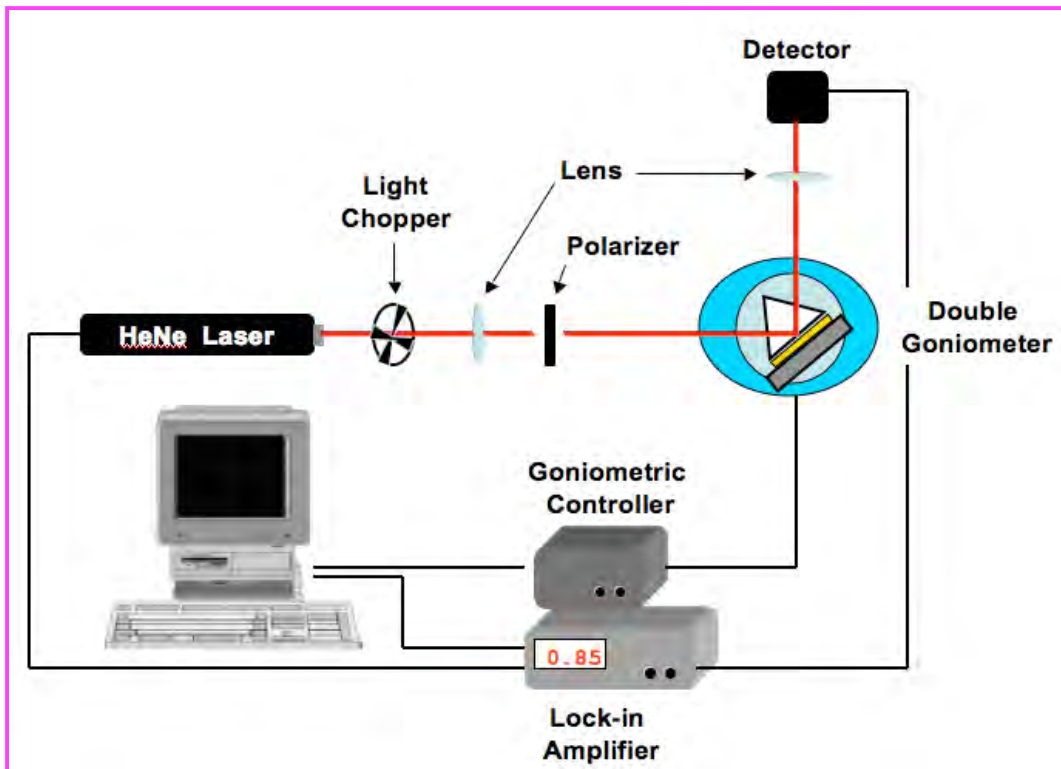
## Angle-shift design 1



Commercial instruments:  
Biacore, Reichert SR7000

- A lens is used to focus the light beam onto the prism base.
- Within the focus, a variety of angles of incidence are covered.
- The angle range (typically a few degrees) is given by the focal length of the lens and the beam diameter.
- The reflection curve is monitored by a PSD or a linear CCD array.
- An array scan of reflectivity vs. pixel number is obtained which cannot be modeled using Fresnel equations.

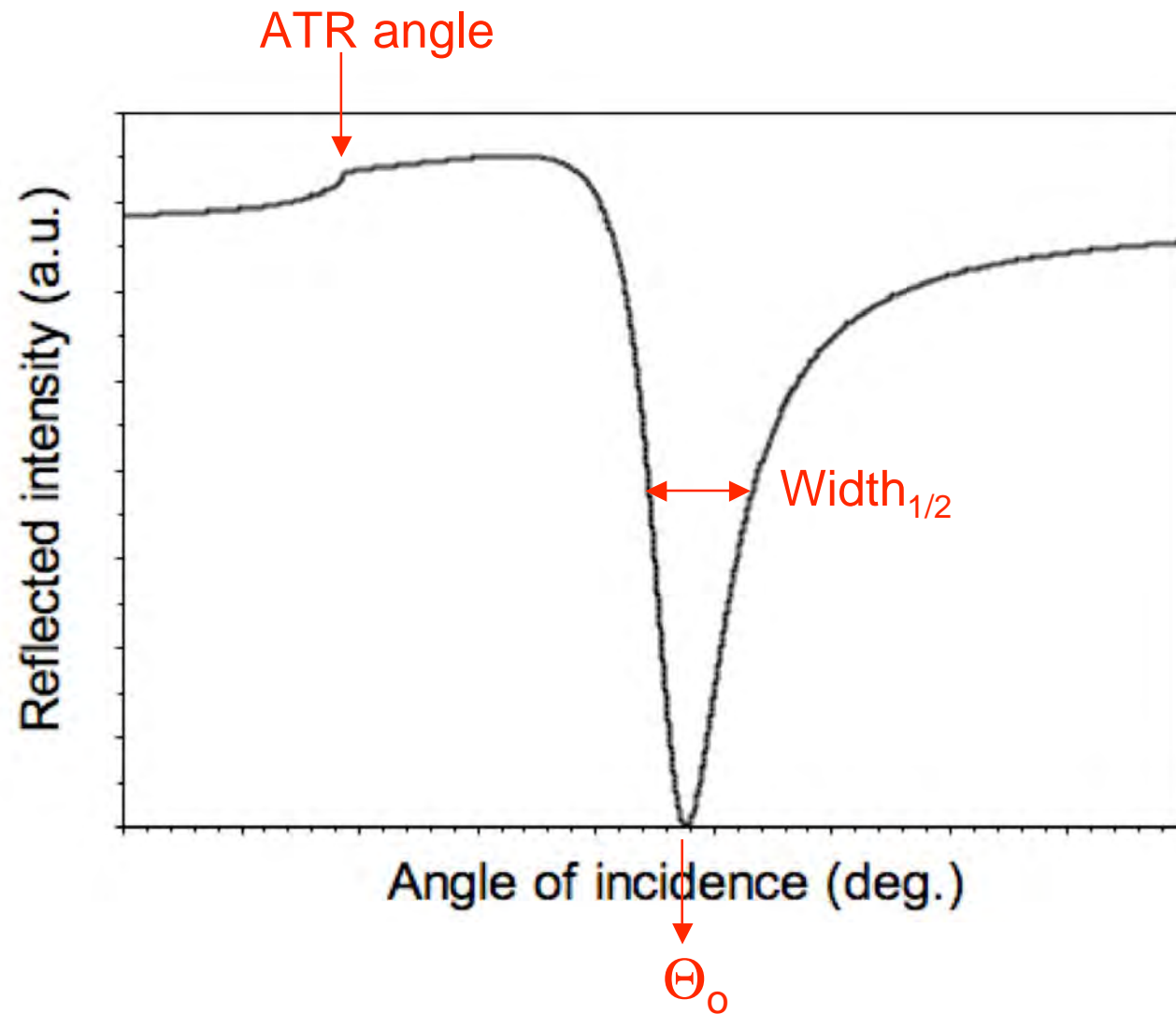
## Angle-shift design 2



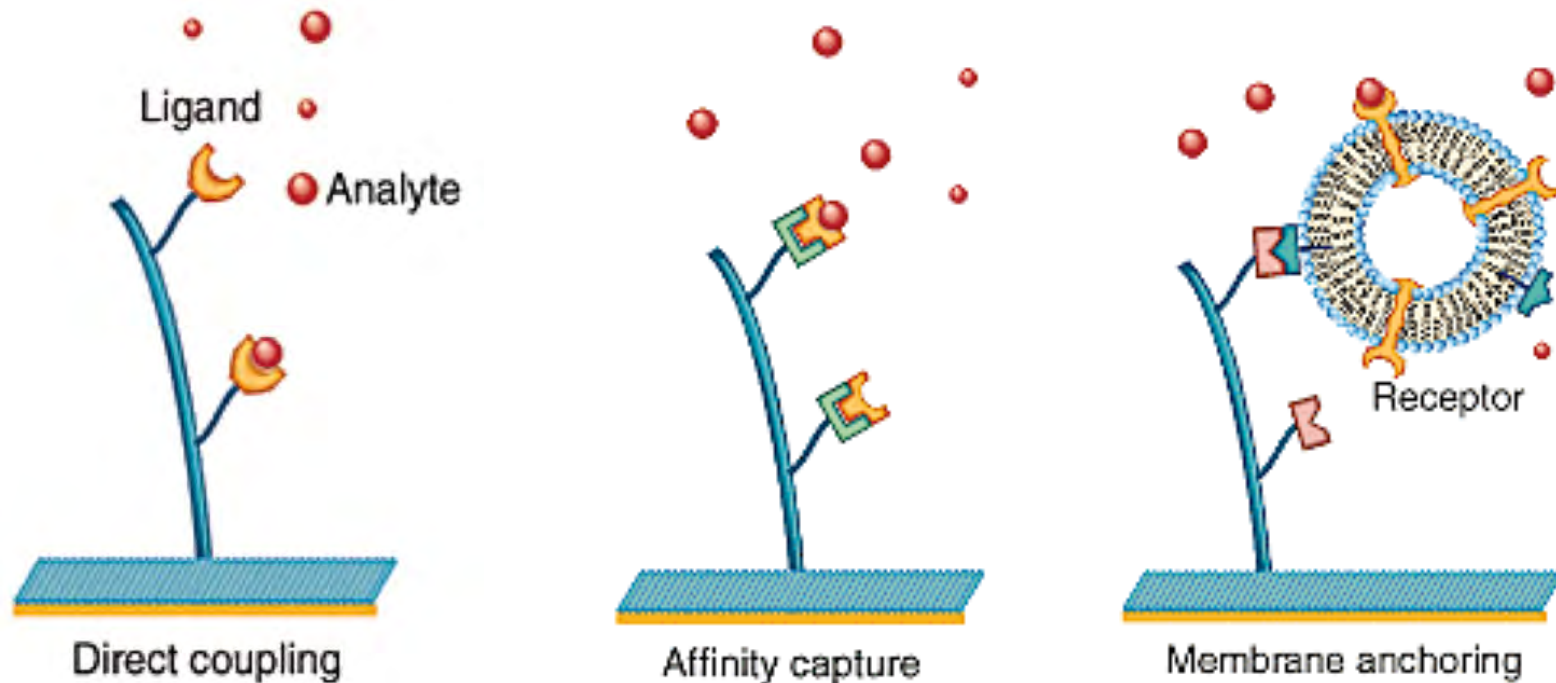
- The laser and detector arm are moved synchronously using a  $\Theta$ - $2\Theta$  goniometer and the reflected light intensity is measured as a function of the angle of incidence.
- The resulting reflectivity vs. incidence angle plot can be modeled using Fresnel equations.

Commercial instruments:  
Biosuplar, Resonant Probes,  
Optrel Multiskop

## SPR angular reflectivity curve



## Surface interactions



- Direct coupling of ligand (binding molecule) to surface
- Indirect, via a capture molecule (eg. a specific IgG)
- Membrane anchoring, where the interacting ligand is on the surface of a captured liposome

## Fabrication of sensing surface

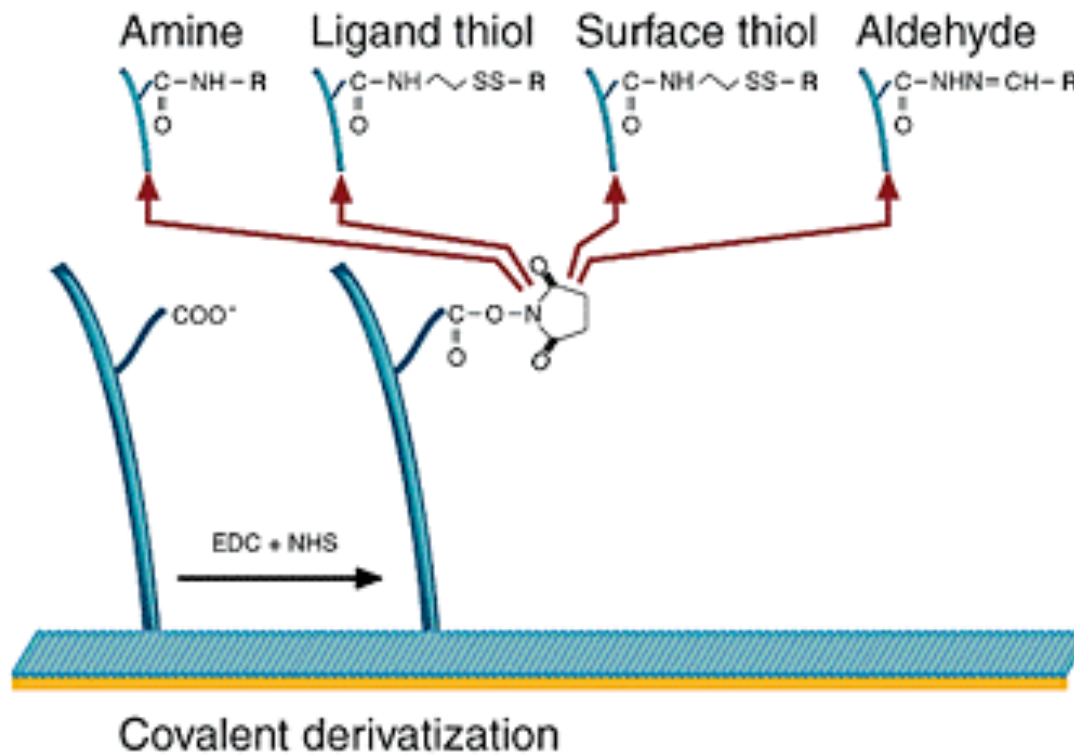
- ❖ Coat glass slides or prism with 45-50 nm of gold
- ❖ Surface Chemistry
  - ❖ Hydrophilic and hydrophobic surfaces
- ❖ Immobilize ligand
  - ❖ Direct coupling - attach ligand chemically via a linker
  - ❖ Capturing - attach a protein that binds your target

References: Jonsen et. al 1991 (Anal Biochem 198, 268-277);  
O'Shannessy et. al., 1992 (Biochem 205, 132-136)

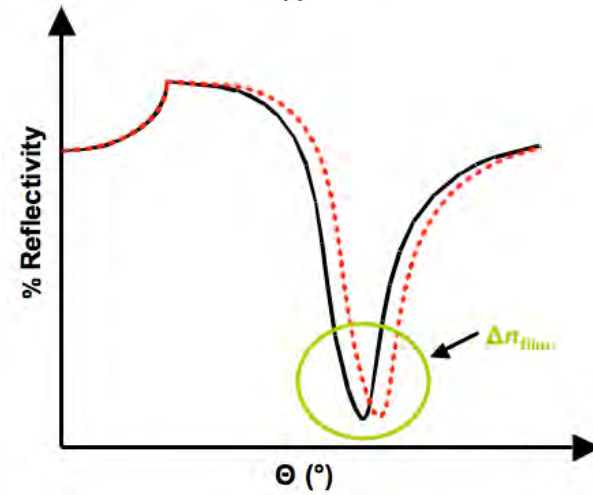
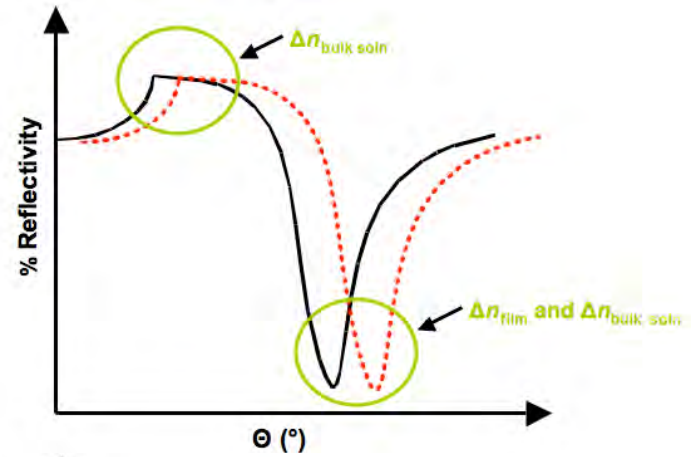
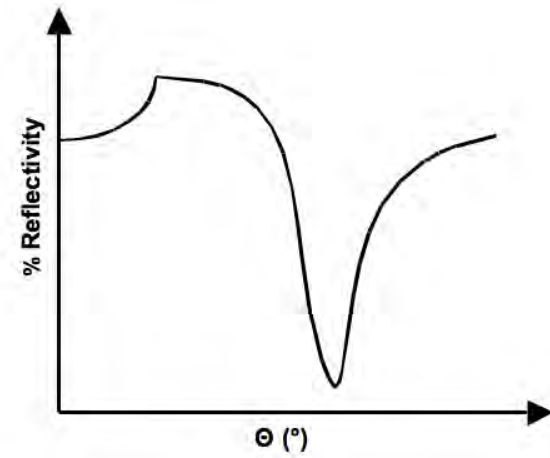
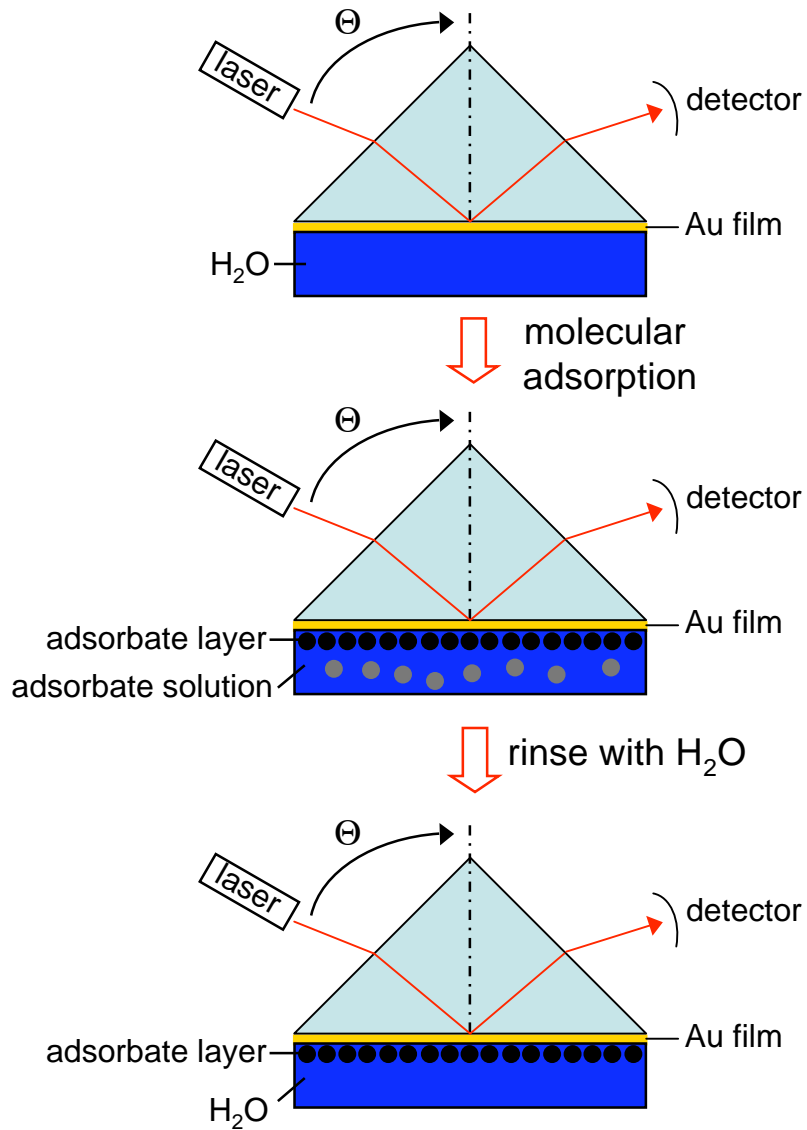


## Ligand coupling chemistry

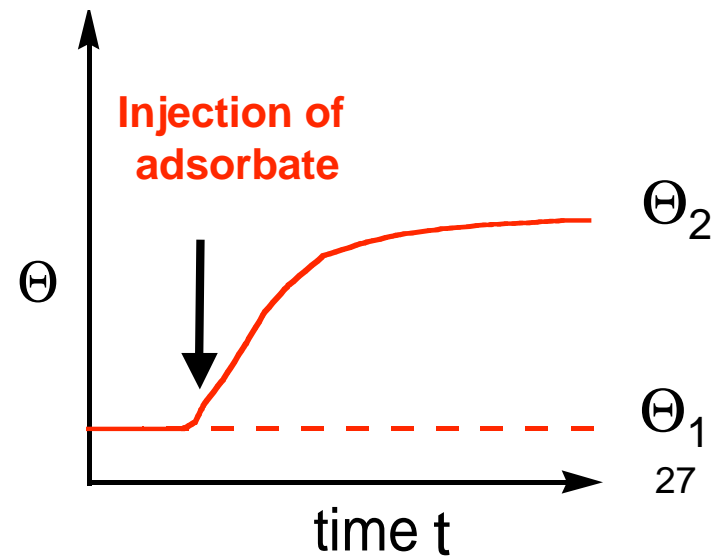
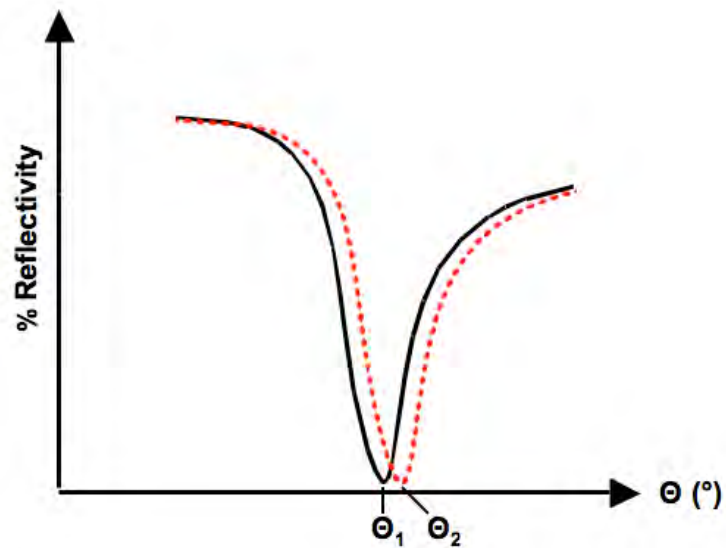
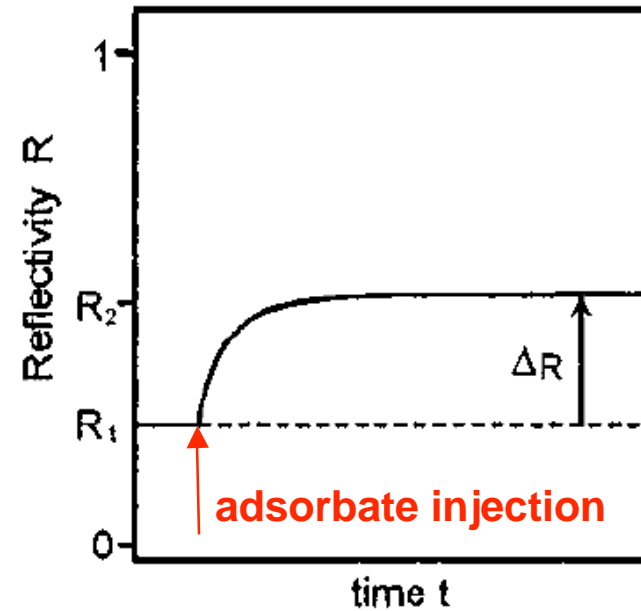
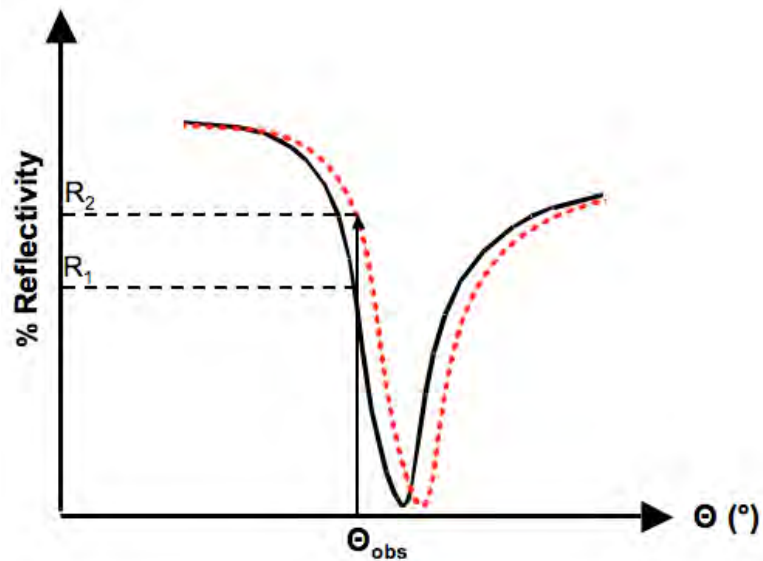
Allows covalent coupling via  $-\text{NH}_2$ ,  $-\text{SH}$ ,  $-\text{CHO}$  &  $-\text{COOH}$  groups:



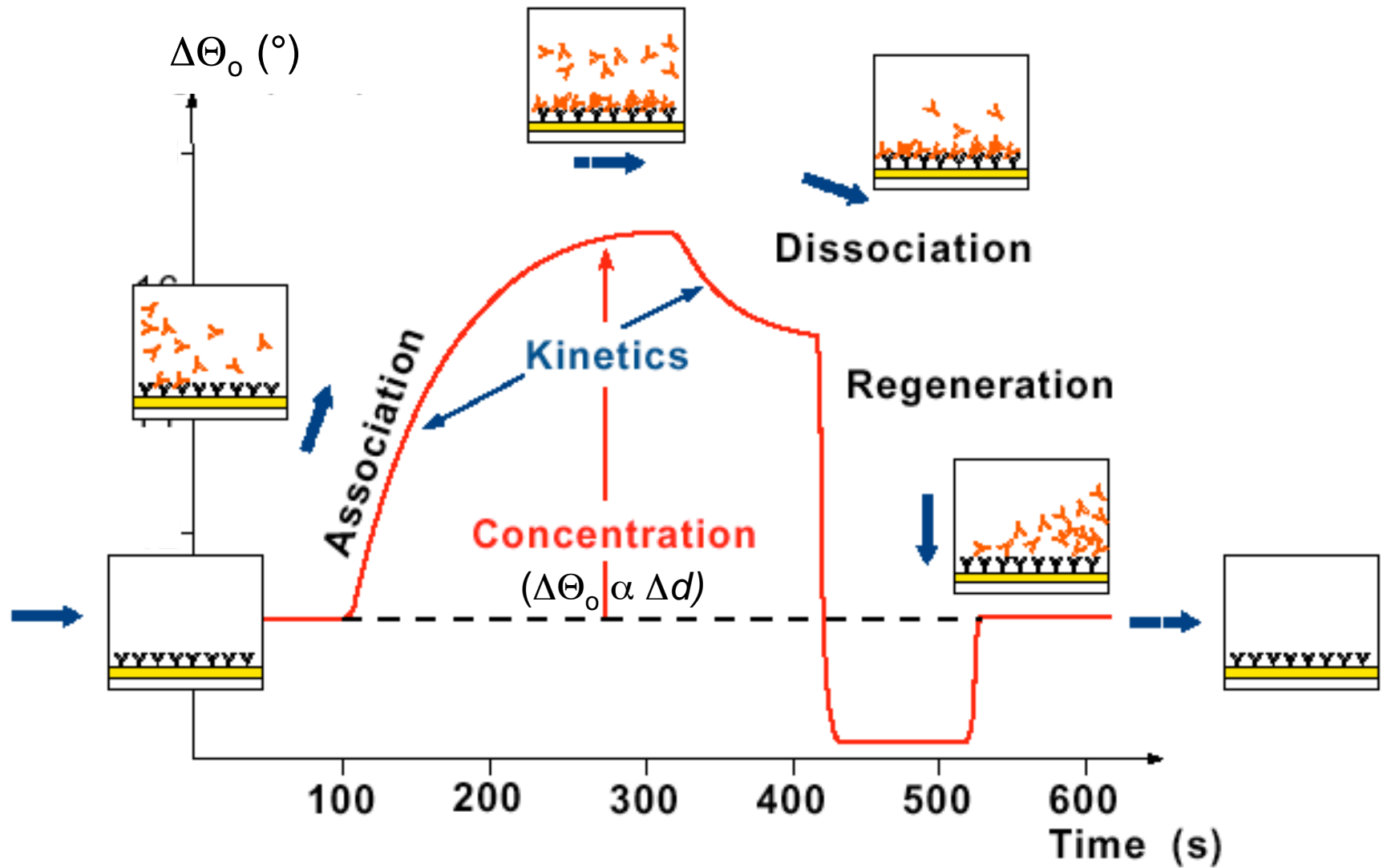
# Molecular adsorption and angle shift



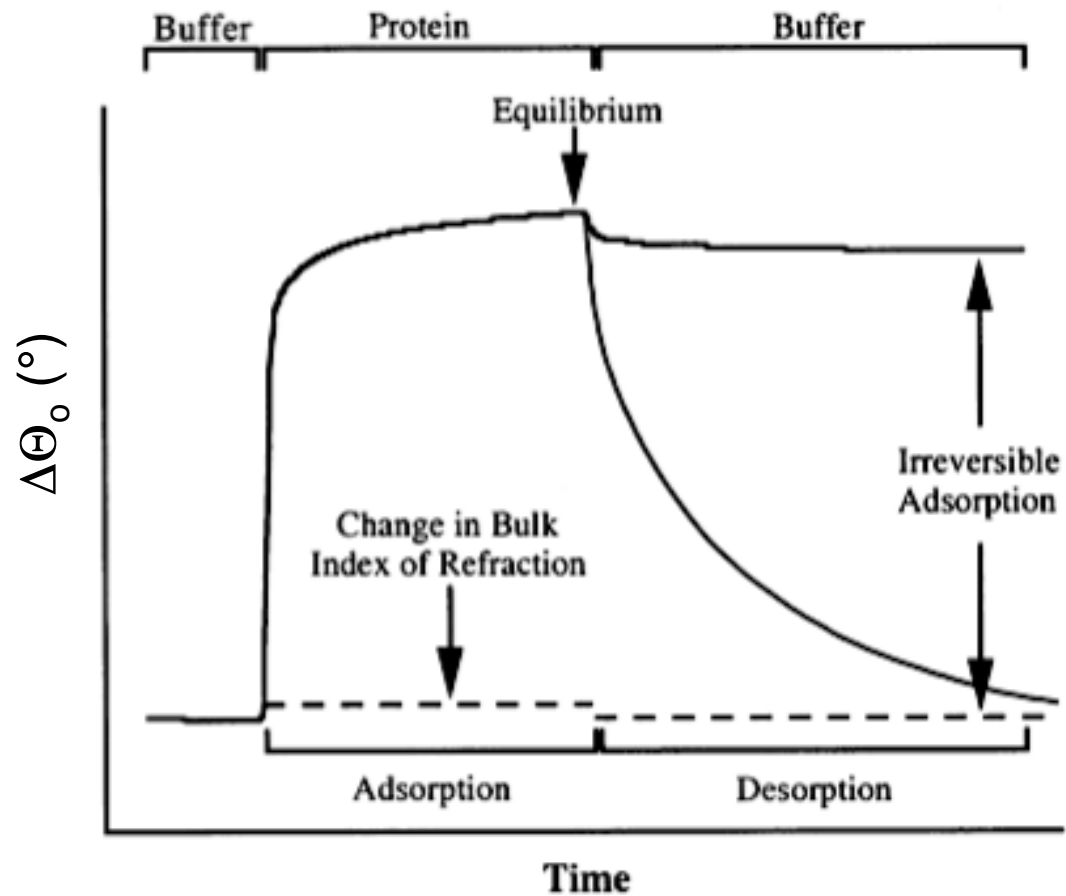
# Monitoring molecular adsorption by SPR



# The sensorgram



## Sensorgrams for reversible and irreversible adsorption

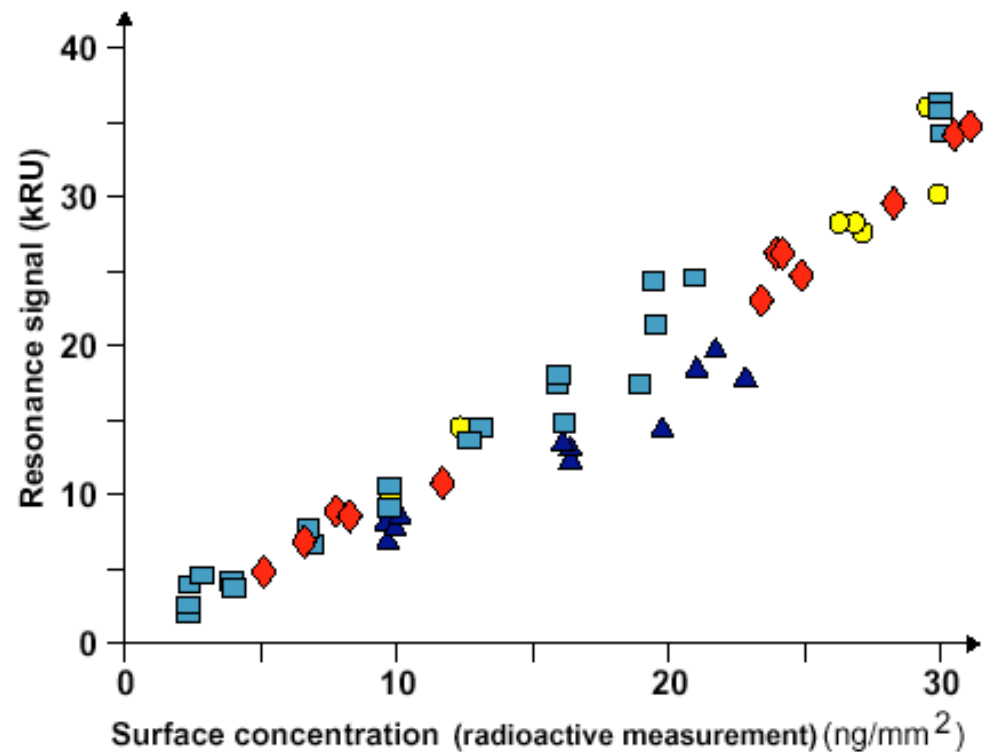


## Analysis of SPR sensorgram

- How much?      *Active surface or bulk concentration*
- How fast?      *Kinetics*
- How strong?    *Affinity*
- How specific?   *Specificity*

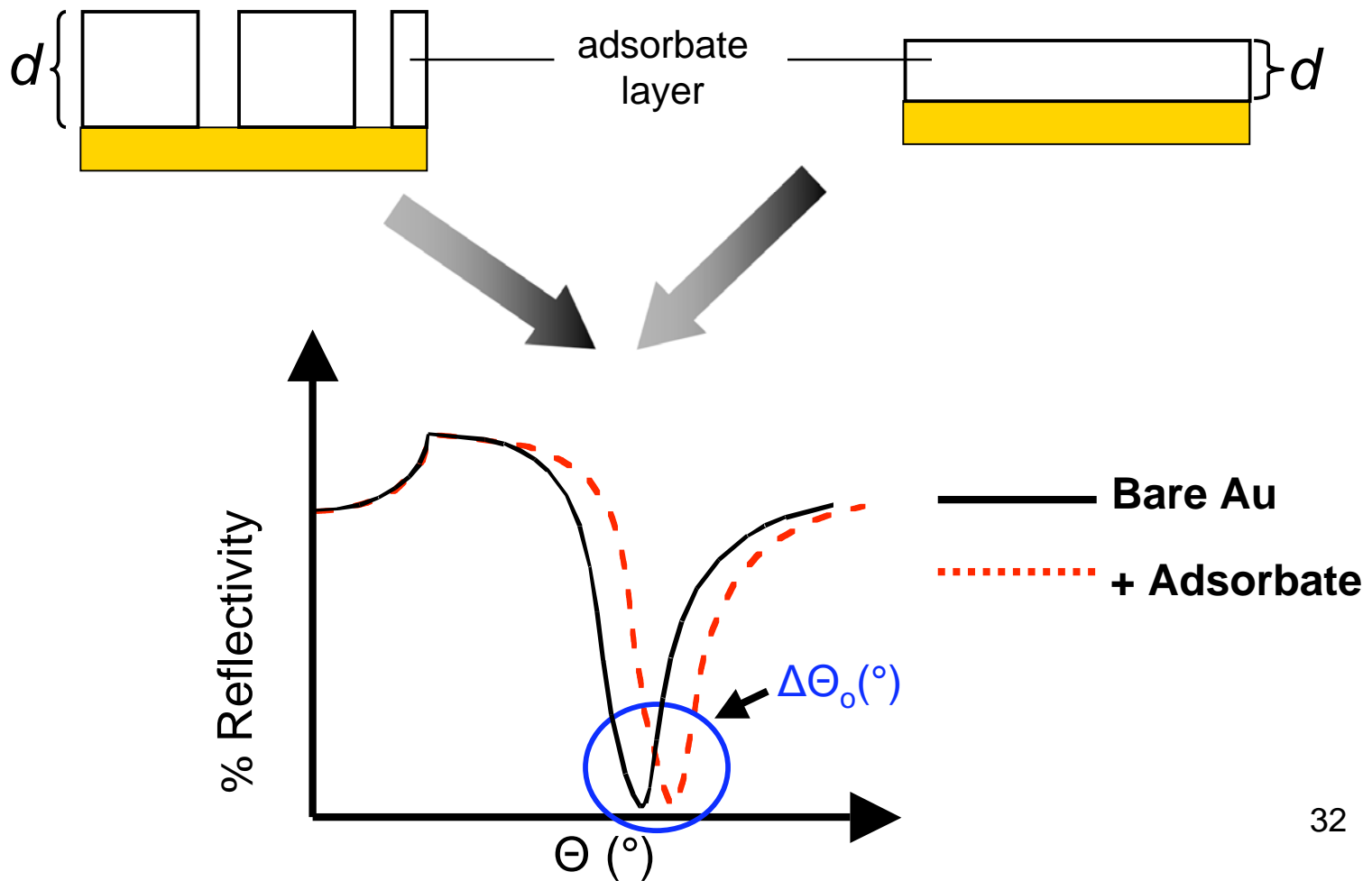
## Surface concentration

- Resonance angle change is proportional to mass change (mass of bound material).
- The change in surface refractive index is essentially the same for a given mass concentration change (allows mass/concentration deductions to be made).
- Example: same specific response for different proteins



## Adsorbate film thickness calculated as an average value

$$\Delta\Theta_o = c_1\Delta n + c_2\Delta d$$





# Modeling with Fresnel equations: Winspall software (freeware, Wolfgang Knoll, MPI-P)

Simulation Parameter

General | Axis | Layer | Euler

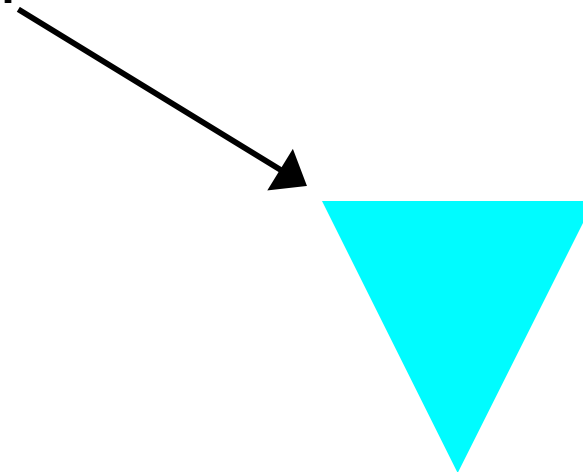
ref-index  
 (e'+ie'')  n ; k

Nr.	Thick. [Å]	Ansiso	Eps-X	
			Real	Imag
1	0	<input type="checkbox"/>	1.76074	
2		<input type="checkbox"/>		
3		<input type="checkbox"/>		
4		<input type="checkbox"/>		
5		<input type="checkbox"/>		
6		<input type="checkbox"/>		
7		<input type="checkbox"/>		

Ok Cancel Exchange

$$\Delta\Theta_0 = c_1\Delta n + c_2\Delta d$$

Prism



## Modeling with Fresnel equations: Wincspall

**Simulation Parameter**

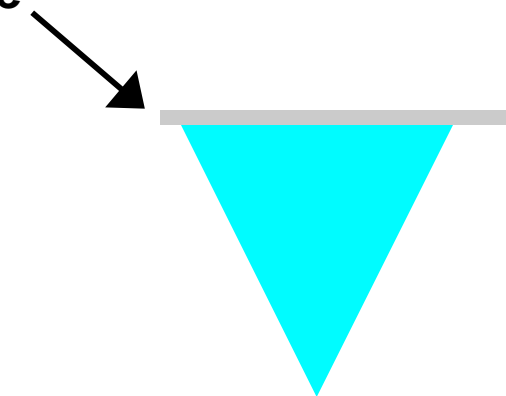
General | Axis | Layer | Euler

ref-index  
 (e'+ie'')  n ; k

Nr.	Thick. [Å]	Ansiso	Eps-X	
			Real	Imag
1	0	<input type="checkbox"/>	1.76074	0
2	0	<input type="checkbox"/>	1.51474	0
3		<input type="checkbox"/>		
4		<input type="checkbox"/>		
5		<input type="checkbox"/>		
6		<input type="checkbox"/>		
7		<input type="checkbox"/>		

Ok  Cancel Exchange

Prism  
Glass Slide



# Modeling with Fresnel equations: Winspall

**Simulation Parameter**

General | Axis | Layer | Euler

ref-index  
 (e'+ie'')  n:k

Nr.	Thick. [Å]	Anisio	Eps-X	
			Real	Imag
1	0	<input type="checkbox"/>	1.76074	0
2	0	<input type="checkbox"/>	1.51474	0
3	12	<input type="checkbox"/>	2.7683	3.3065
4	480	<input type="checkbox"/>	0.1805	4.856
5		<input type="checkbox"/>		
6		<input type="checkbox"/>		
7		<input type="checkbox"/>		

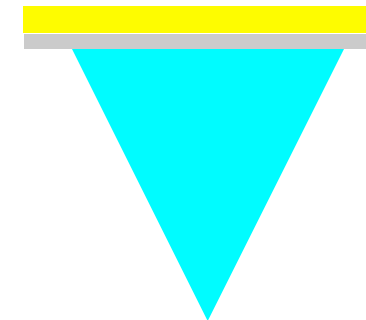
Ok Cancel Exchange

Prism

Glass Slide

Ti

Au



# Modeling with Fresnel equations: Winspall

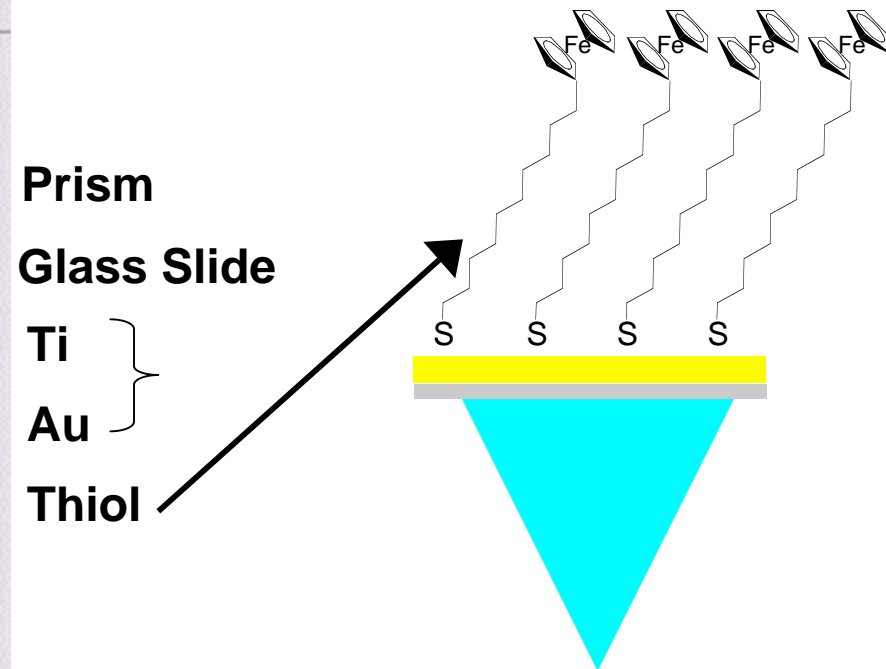
**Simulation Parameter**

General | Axis | Layer | Euler

ref-index  
 (e'+ie'')  n:k

Nr.	Thick. [Å]	Ansiso	Eps-X	
			Real	Imag
1	0	<input type="checkbox"/>	1.76074	0
2	0	<input type="checkbox"/>	1.51474	0
3	12	<input type="checkbox"/>	2.7683	3.3065
4	480	<input type="checkbox"/>	0.1805	4.856
5	18.9	<input type="checkbox"/>	1.464	0
6		<input type="checkbox"/>		
7		<input type="checkbox"/>		

Ok Cancel Exchange



# Modeling with Fresnel equations: Winspall

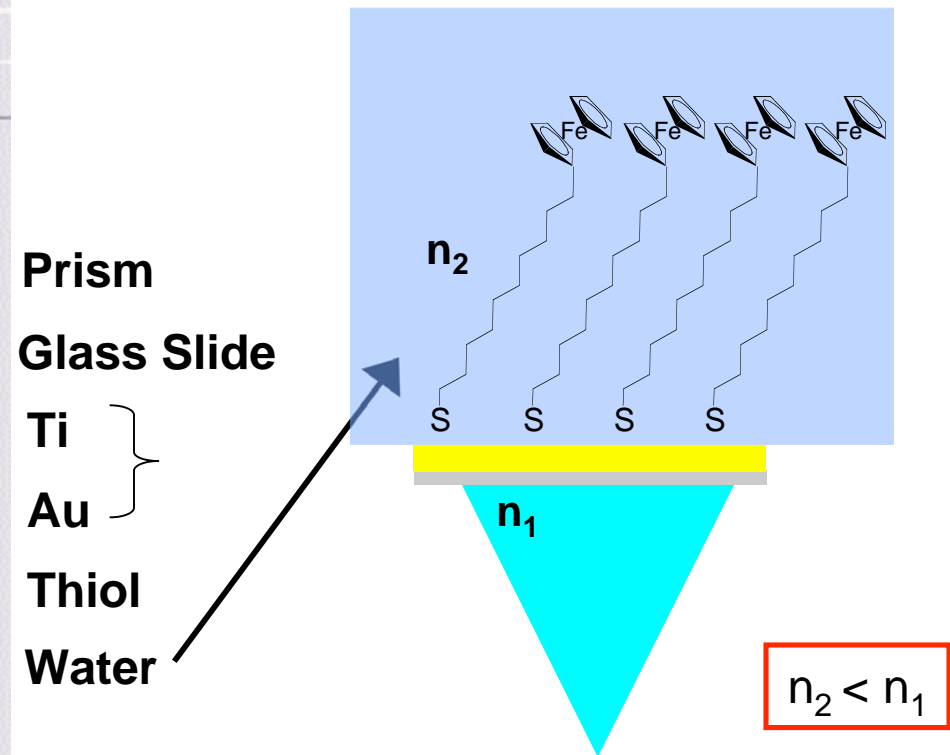
**Simulation Parameter**

General | Axis | Layer | Euler

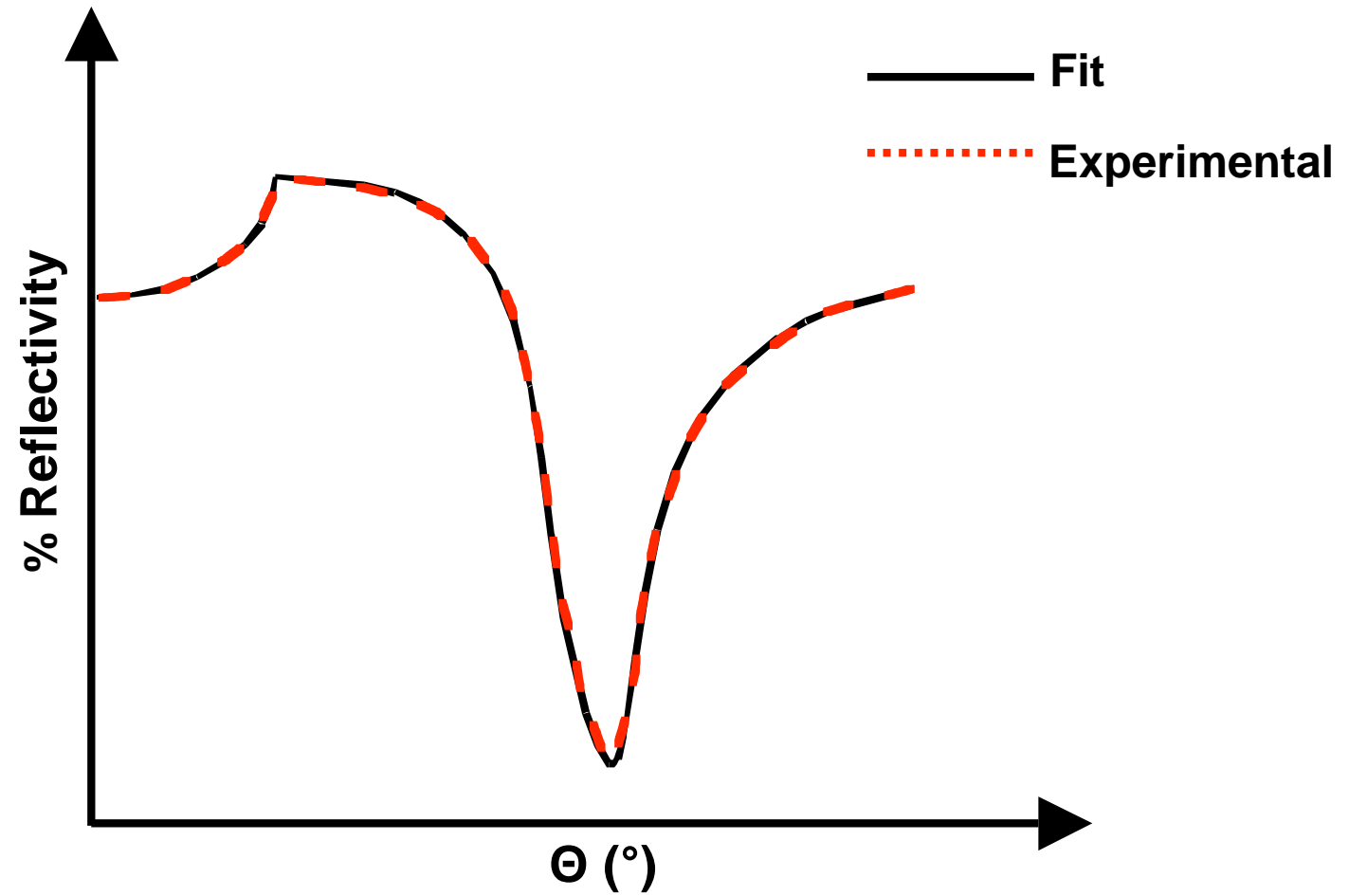
ref-index  
 (e'+ie'')  n:k

Nr.	Thick. [Å]	Ansio	Eps-X	
			Real	Imag
1	0	<input type="checkbox"/>	1.76074	0
2	0	<input type="checkbox"/>	1.51474	0
3	12	<input type="checkbox"/>	2.7683	3.3065
4	480	<input type="checkbox"/>	0.1805	4.856
5	18.9	<input type="checkbox"/>	1.464	0
6	0	<input type="checkbox"/>	1.328	0
7		<input type="checkbox"/>		

Ok
  Cancel



## SPR profile fit





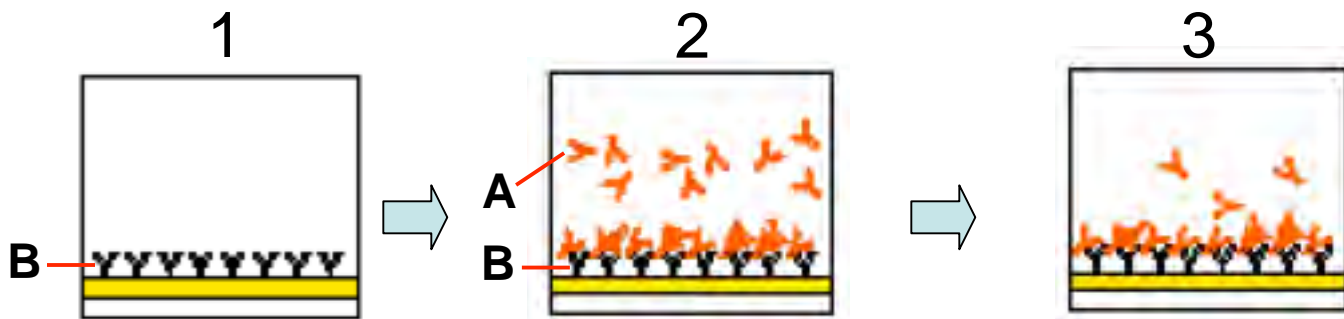
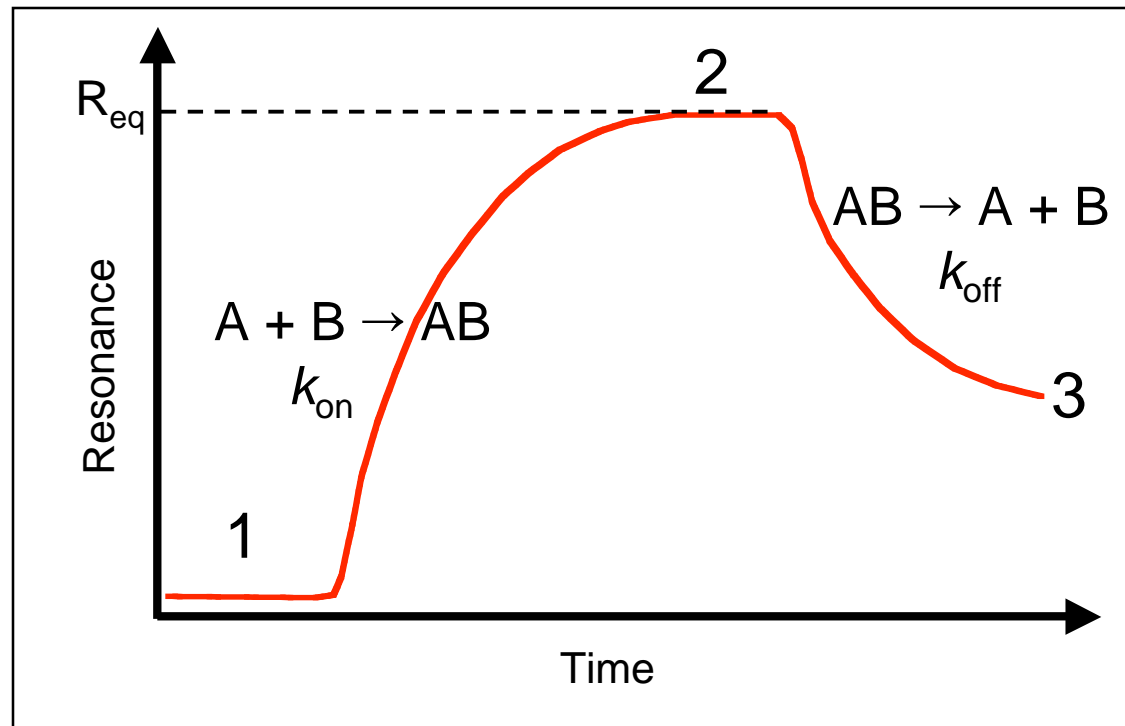
## Calculation of surface concentration

- ❖ Determine adsorbate film thickness ( $d_{\text{film}}$ ) from Fresnel fitting of the experimental angular reflectivity curve
- ❖ Determine the incremental change in the bulk refractive index with concentration of the adsorbate ( $\partial n_{\text{adsorbate}} / \partial c$ ) using refractometry
- ❖ The surface excess ( $\Gamma$  / mol·cm<sup>-2</sup>) is calculated according:

$$\Gamma = d(n_{\text{film}} - n_{\text{solvent}}) \frac{1}{\partial n_{\text{adsorbate}} / \partial c}$$

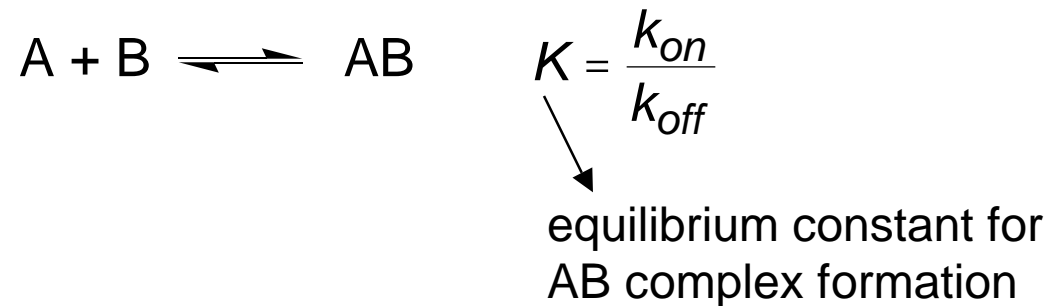
$n$  of hydrocarbon films  $\approx$  1.45-1.50 (589-633 nm)

# Binding kinetics





## Simple binding kinetics



$$\frac{d[AB]}{dt} = k_{on}[A][B] - k_{off}[AB]$$

- If flow rate of A is sufficiently high,  $[A] = a_0$
- We can also write  $[B] = b_0 - [AB]$
- SPR signal  $\propto [AB]$
- $R_{max} \propto b_0$  (measured if all B bound to A)

- We may write:

$$\frac{dR}{dt} = k_{on}a_0(R_{max} - R) - k_{off}R = k_{on}a_0R_{max} - (k_{on}a_0 + k_{off})R$$

- At equilibrium  $R = R_{eq}$  and  $dR/dt = 0$ .

- It follows that:  $R_{eq} = R_{max} \left( \frac{a_0 K}{a_0 K + 1} \right)$

- The value of  $K$  can be obtained from measurements of  $R_{eq}$  for a series of  $a_0$

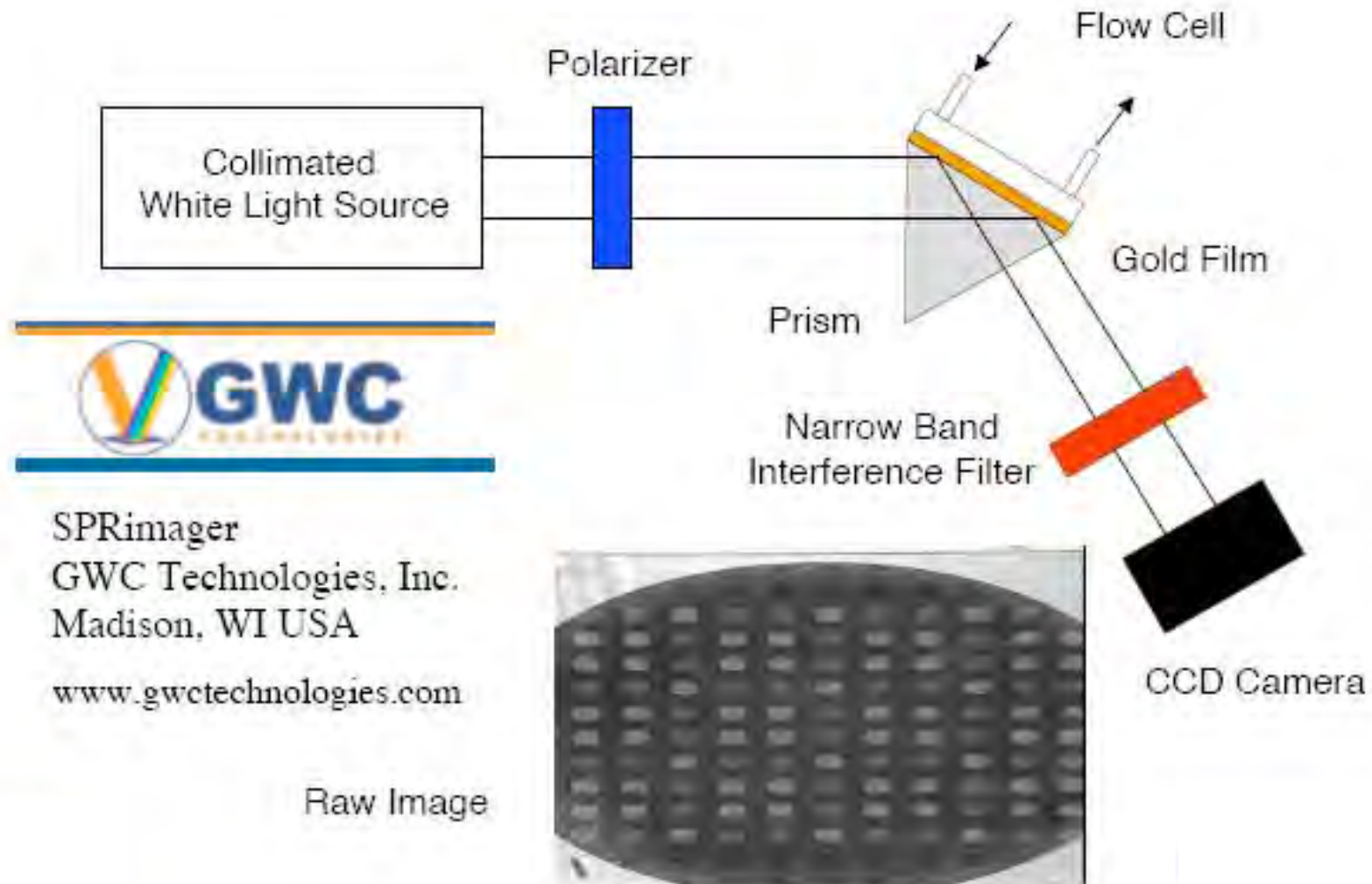
## Mass transport considerations

- Do mass transport limitations impact the rate constants?
  - Yes, if binding rate  $>$  diffusion rate
  - Introduces gradients
  - Myszka DG, et. al., “Extending the range of rate constants available from BIACORE: interpreting mass transport-influenced binding data”, *Biophys J* 1998, 75: 583-594.

## SPR-based measurements

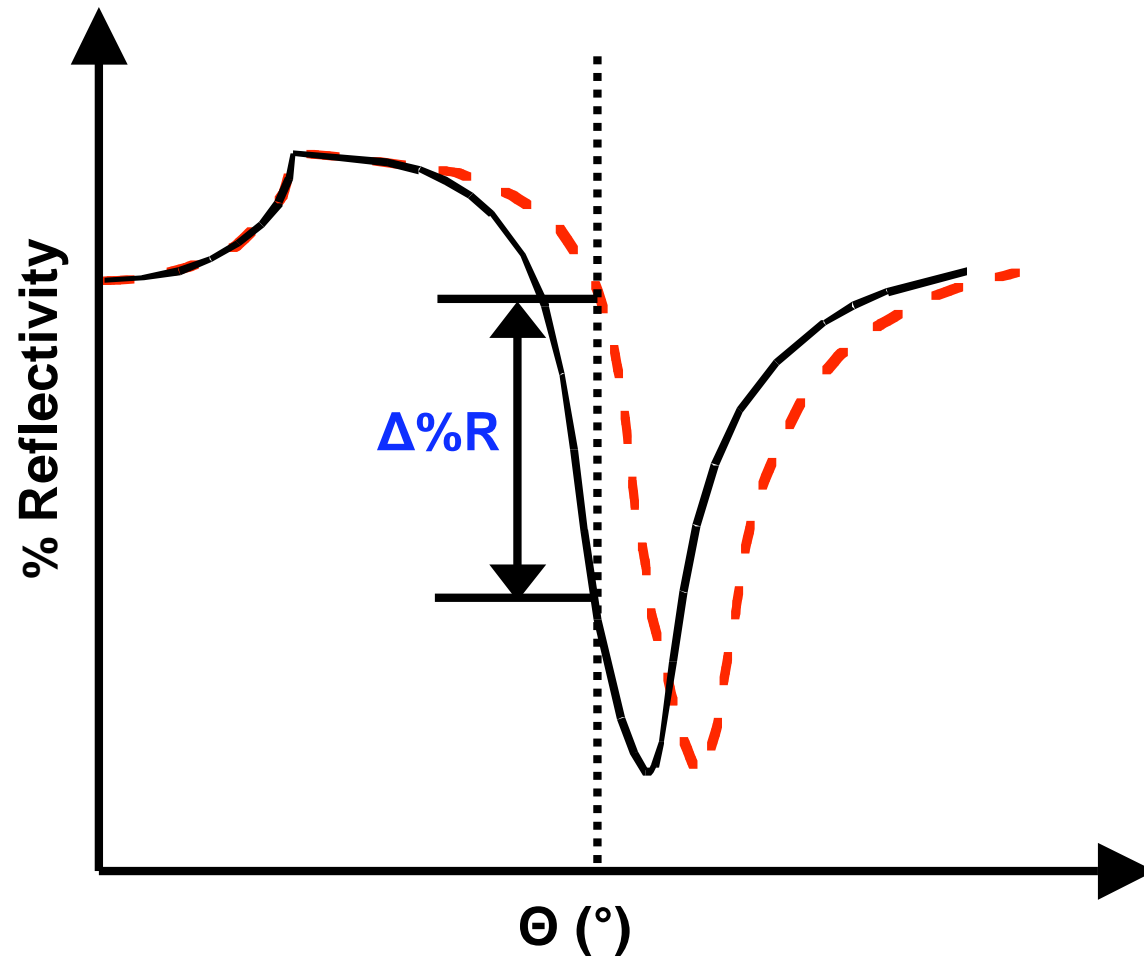
- Resonance angle shift
- **Imaging/microscopy**
- Wavelength shift (FT-SPR)

# SPR imaging apparatus



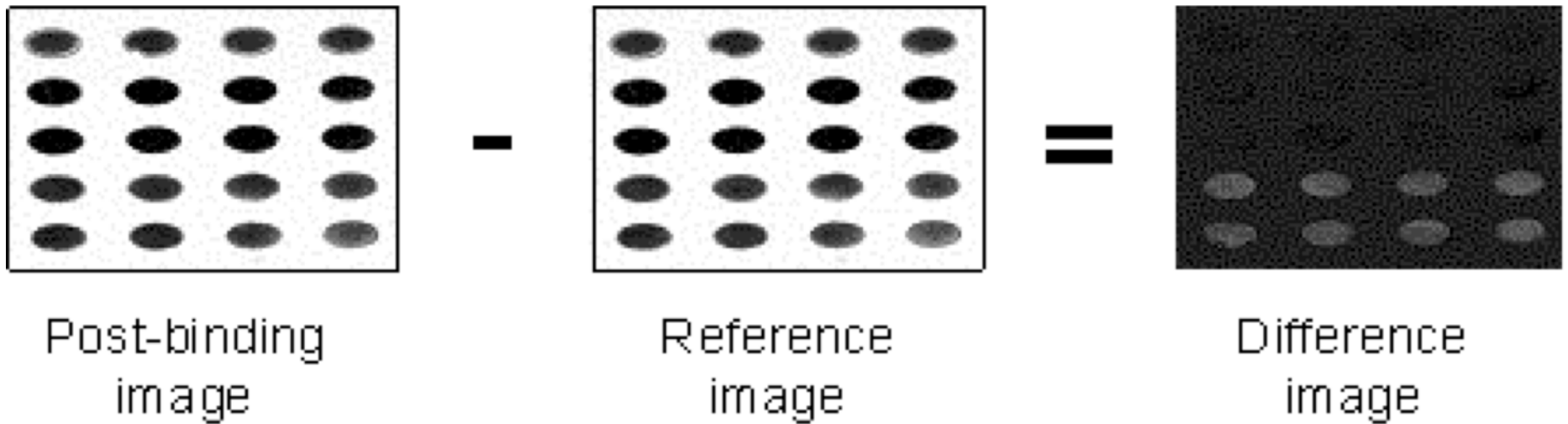
SPRImager  
GWC Technologies, Inc.  
Madison, WI USA  
[www.gwctechnologies.com](http://www.gwctechnologies.com)

## SPR Imaging



In SPR “imaging”, the reflectivity change,  $\Delta\%R$ , is determined by measuring the SPR signal at a fixed angle of incidence before and after selective molecular adsorption across a fixed surface.

## SPR Imaging - Image processing



Z-resolution  $\approx 1-2 \text{ \AA}$   
X-Y resolution  $\approx \text{microns}$

## Problems of SPR

- Limited to choice of metal which results in SPR
- Sample preparation
  - Attaching probe to metal surface can prove difficult
- Non-specific interactions
  - Good news- Everything has an SPR signal!
  - Bad news- Everything has an SPR signal!
- Refractive index is temperature dependent



## Future of SPR

- Combination of SPR with various surface analytical techniques:
  - Electrochemistry
  - Quartz Crystal Microbalance (QCM)
  - Ellipsometry
  - Scanning Probe Microscopy